

# **MOSFET**

## OptiMOS<sup>™</sup> 5 Power-Transistor, 40 V

#### **Features**

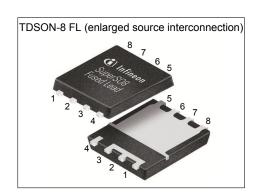
- Battery powered application
- LV motor drives
- Very low on-resistance R<sub>DS(on)</sub>
- 100% avalanche tested
- Superior thermal resistance
- N-channel
- Pb-free lead plating; RoHS compliantHalogen-free according to IEC61249-2-21
- 175 °C rated

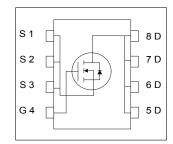
### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Table 1 **Key Performance Parameters** 

Parameter Value		Unit	
<b>V</b> <sub>DS</sub>	40	V	
R <sub>DS(on),max</sub>	5.8	mΩ	
I <sub>D</sub>	63	А	
Qoss	13	nC	
Q <sub>G</sub> (0V10V)	12	nC	











Type / Ordering Code	Package	Marking	Related Links
ISC058N04NM5	TDSON-8 FL	58N04NM5	-



# **Table of Contents**

escription	1
1aximum ratings	3
hermal characteristics	3
lectrical characteristics	4
lectrical characteristics diagrams	6
ackage Outlines	0
evision History	1
rademarks 1	1
nisclaimer	1



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Davamatar	Counch of	Values			11	Note / Took Open distant	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - - -	- - -	63 44 56 40 17	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =7 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =7 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm THJA}$ =50 °C/W <sup>2</sup> )	
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	252	Α	<i>T</i> <sub>C</sub> =25 °C	
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	30	mJ	$I_D$ =25 A, $R_{GS}$ =25 $\Omega$	
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-	
Power dissipation	P <sub>tot</sub>	-	-	42 3.0	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>THJA</sub> =50 °C/W <sup>2)</sup>	
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1 55/175/56	

#### 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
rarameter	Syllibol	Min.	Тур.	Max.	Oilit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	-	3.6	°C/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	20	°C/W	-
Device on PCB, 6 cm² cooling area	R <sub>thJA</sub>	_	-	50	°C/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher Tcase please refer to Diagram 2. De-rating will be required based on the actual environmental

conditions.

2) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

<sup>&</sup>lt;sup>4)</sup> See Diagram 13 for more detailed information



# 3 Electrical characteristics at $T_j$ =25 °C, unless otherwise specified

Table 4 **Static characteristics** 

Danamatan	Ob. a.l.	Values				Note / Test Condition	
Parameter	Symbol	Min. Typ. Max.		Unit			
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	40	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	2.2	-	3.4	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=13\ \mu{\rm A}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1 100	μΑ	V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	4.5 5.2	5.8 7.2	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =31 A V <sub>GS</sub> =7 V, I <sub>D</sub> =31 A	
Gate resistance	R <sub>G</sub>	-	2.0	2.9	Ω	-	
Transconductance	<b>g</b> fs	-	83	-	S	$ V_{DS}  \ge 2 I_D R_{DS(on)max}, I_D = 31 \text{ A}$	

Table 5 **Dynamic characteristics** 

Davamatav	Complete	Values			11	Nata / Tank Oam Hittan
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	870	1100	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =20 V, <i>f</i> =1 MHz
Output capacitance <sup>1)</sup>	Coss	-	310	400	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =20 V, <i>f</i> =1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	-	30	52	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =20 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	4	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	2	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{\sf d(off)}$	-	8	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	2	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Gate charge characteristics<sup>2)</sup> Table 6

	Oh. a.l.	Values			11	Nata / Tank Oan distant	
Parameter	Symbol	Min.	Тур. Мах.		Unit	Note / Test Condition	
Gate to source charge	Q <sub>gs</sub>	-	4	-	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge at threshold	$Q_{g(th)}$	-	2	-	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Gate to drain charge <sup>1)</sup>	$Q_{ m gd}$	-	2	3	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Switching charge	Q <sub>sw</sub>	-	4	-	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total <sup>1)</sup>	Qg	-	12	16	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Gate plateau voltage	<b>V</b> <sub>plateau</sub>	-	4.5	-	V	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =31 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	11	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V	
Output charge	Qoss	-	13	-	nC	V <sub>DD</sub> =20 V, V <sub>GS</sub> =0 V	

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

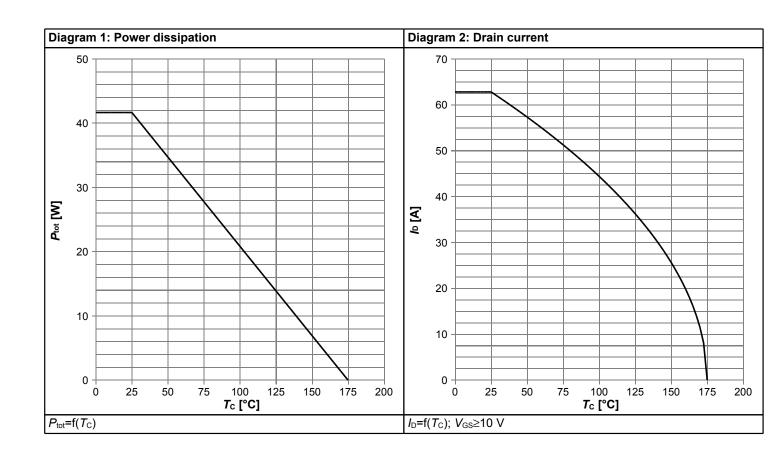


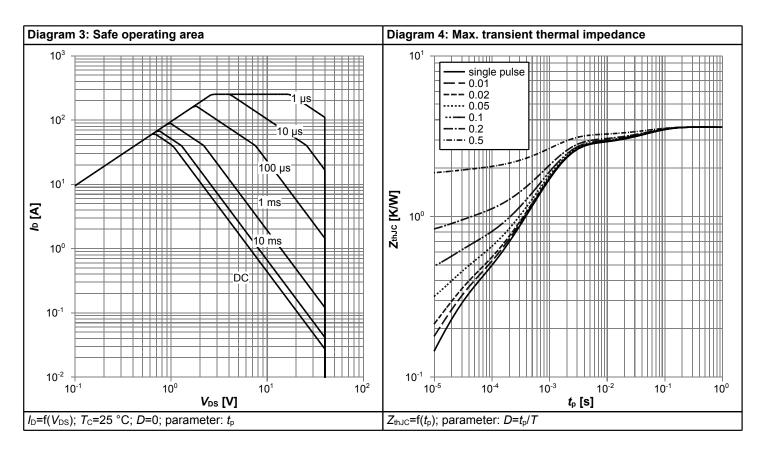
### Table 7 Reverse diode

Davamatav	Cymphal	Values			11!4	Nata / Tank Oam didian	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode continuous forward current	Is	-	-	42	Α	T <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	252	Α	T <sub>C</sub> =25 °C	
Diode forward voltage	V <sub>SD</sub>	-	0.89	1	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =31 A, T <sub>j</sub> =25 °C	
Reverse recovery time	<i>t</i> <sub>rr</sub>	-	30	-	ns	$V_R$ =20 V, $I_F$ =50 A, $di_F/dt$ =100 A/ $\mu$ s	
Reverse recovery charge	Qrr	-	24	-	nC	$V_R$ =20 V, $I_F$ =50 A, $dI_F/dI_T$ =100 A/ $\mu$ s	

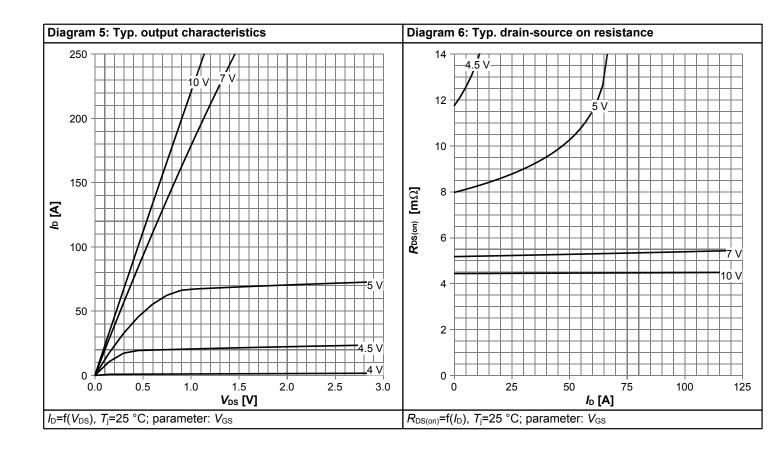


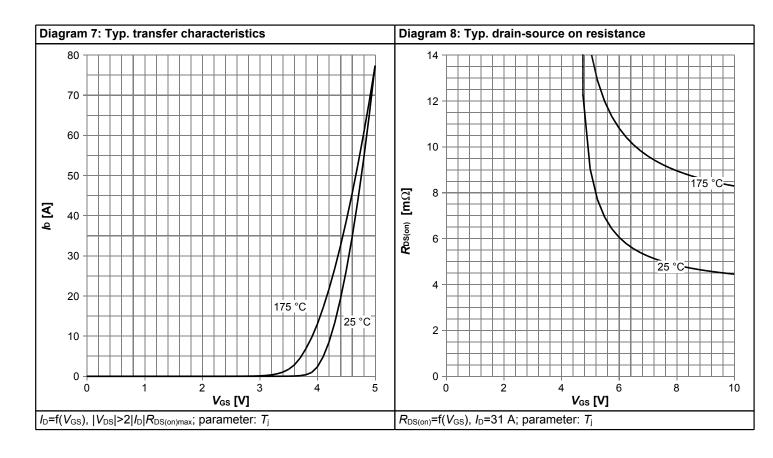
# 4 Electrical characteristics diagrams



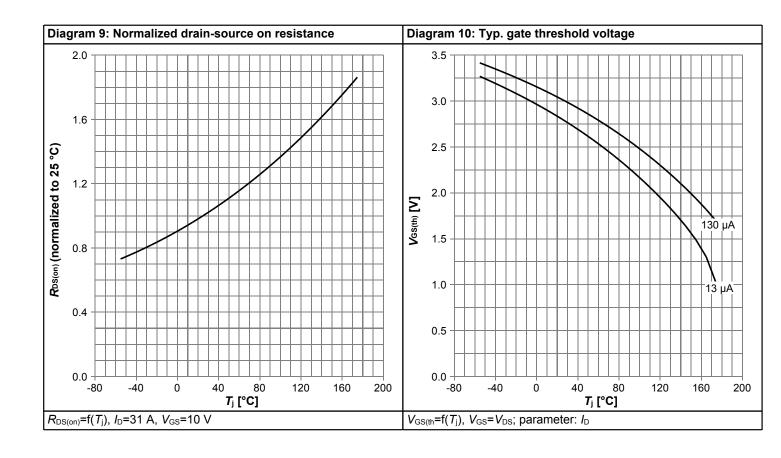


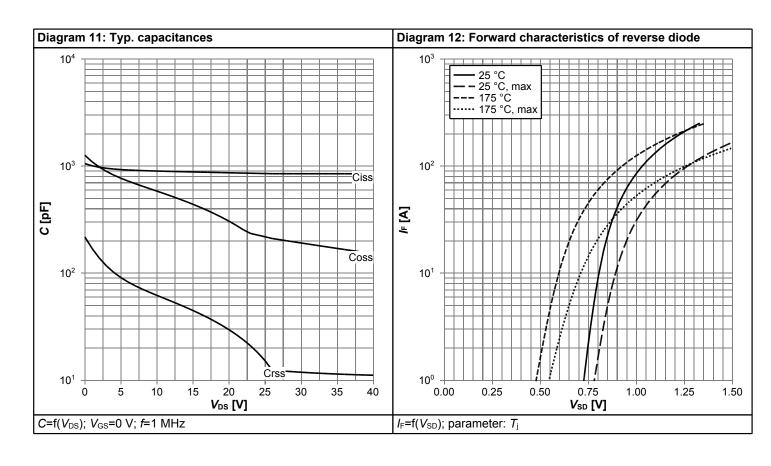




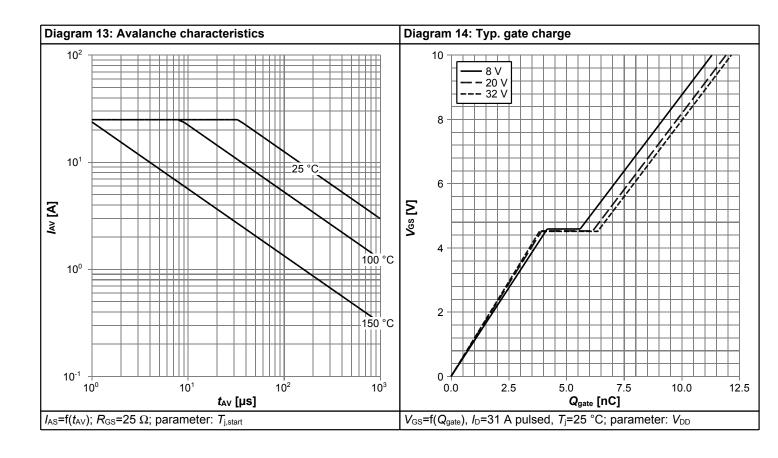


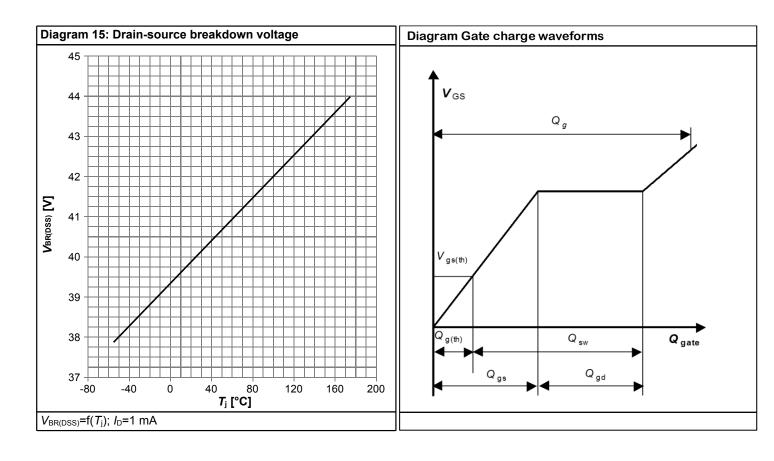






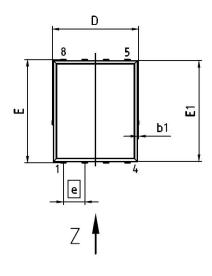


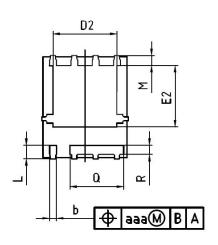


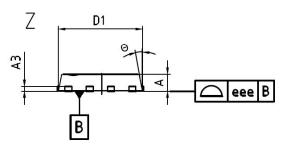




# 5 Package Outlines







DIM	MILLI	METERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	0.90	1.10	0.035	0.043		
A3	0.25	(REF)	0.011	(REF)		
b	0.34	0.54	0.013	0.021		
b1	0.02	0.22	0.001	0.009		
D	5.15	(BSC)	0.203	(BSC)		
D1	5.00	(BSC)	0.197	(BSC)		
D2	3.70	4.40	0.146	0.173		
E	6.15	(BSC)	0.242 (BSC)			
E1	6.00	(BSC)	0.236 (BSC)			
E2	3.40	3.80	0.134	0.150		
е	1.27	(BSC)	0.050 (BSC)			
N		8	8			
L	0.74	0.84	0.029	0.033		
M	0.45	0.66	0.018	0.026		
Θ	8.5°	12°	8.5°	12°		
Q	3.15	3.25	0.124	0.128		
R	0.48	0.58	0.019	0.023		
aaa	0	.25	0.0	010		
eee	0	.08	0.0	003		

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Figure 1 Outline TDSON-8 FL, dimensions in mm/inches

# OptiMOS<sup>™</sup> 5 Power-Transistor, 40 V





#### **Revision History**

ISC058N04NM5

Revision: 2020-03-23, Rev. 2.1

Previous Revision

	1 Toviodo Novición							
Revision	Date	Subjects (major changes since last revision)						
2.0	2020-01-30	Release of final version						
2.1	2020-03-23	Update condition Id pulse, Features and footnotes						

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